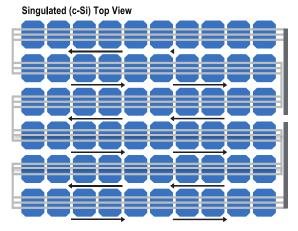


Module Differences: Singulated vs Monolithic

Singulated (Wafer-based) Architecture



Singulated (c-Si) Side Views

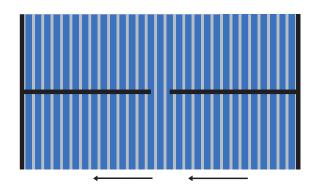


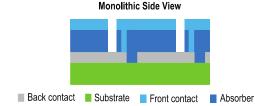
Pro: Can sort cells to match performance

Con: More handling and failure points

Monolithic (Thin-film) Architecture

Monolithic Top View

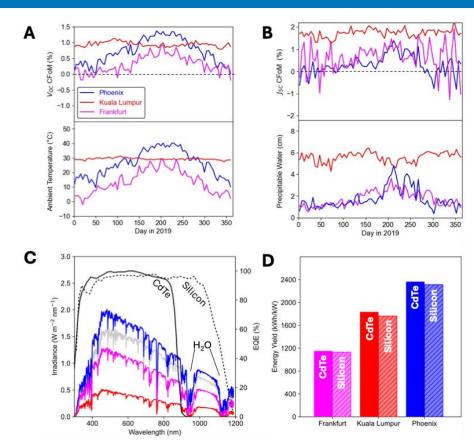




Pro: All but connection to j-box is automatic Lower cost, fewer failure points Con: Large area uniformity can be challenging

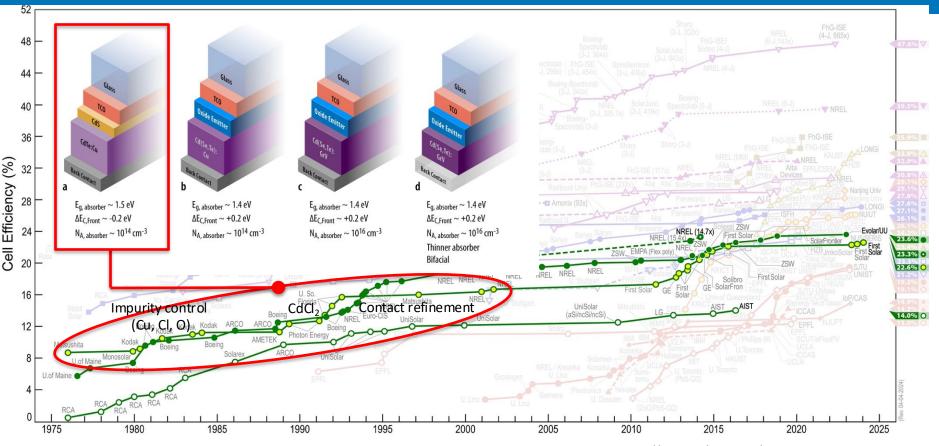
Comparative Energy Yield of CdTe Relative to Si

- CdTe has a favorable temperature coefficient (-0.32%/°C vs -0.34%/°C)
 - TOPCON → -0.29%/°C
 - SHJ → -0.21%/°C
 - Cd(Se,Te):As → -0.23/°C
- CdTe has less spectral dependence from humidity
- CdTe has lower bifaciality
 - Si \rightarrow 80-90% bifaciality
 - CdTe → ~15% bifaciality (today)



1. B.E. Sartor, et al. "Roadmap to 100 GW_{DC}: Scientific and Supply Chain Challenges for CdTe Photovoltaics" (under review)

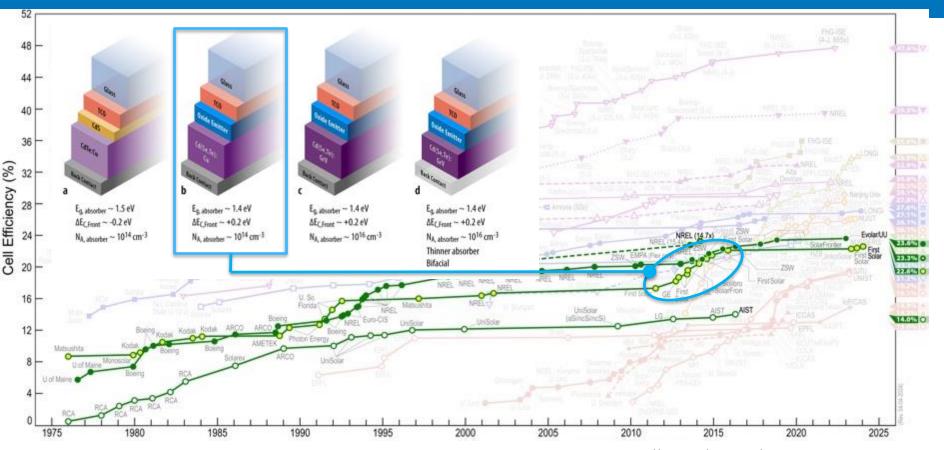
Evolution of Cadmium Telluride Photovoltaics



P. Verlinden, et al., "Photovoltaic device innovation for a solar future" Device, 1, 100013 (2023). https://doi.org/10.1016/j.device.2023.100013

PVCe IITech 2025 NREL

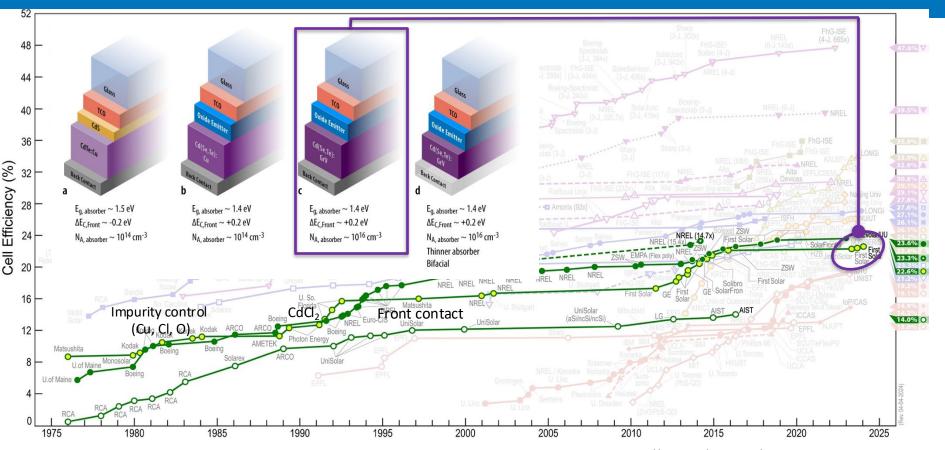
Evolution of Cadmium Telluride Photovoltaics



P. Verlinden, et al., "Photovoltaic device innovation for a solar future" Device, 1, 100013 (2023). https://doi.org/10.1016/j.device.2023.100013

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Evolution of Cadmium Telluride Photovoltaics



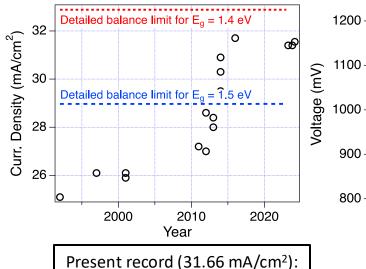
P. Verlinden, et al., "Photovoltaic device innovation for a solar future" Device, 1, 100013 (2023). https://doi.org/10.1016/j.device.2023.100013

PVCe IITech 2025 NREL

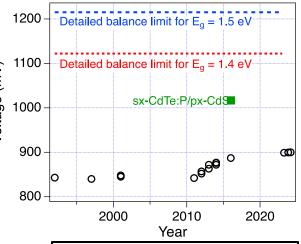
Entitlements

Detailed balance limit (25°C, 1 sun, AM1.5G)¹

	E _g (eV)	J _{sc} (mA/cm²)	V _{oc} (mV)	FF (%)	Eff. (%)
CdTe	1.5	28.97	1215	89.9	31.64
CdSeTe	1.4	32.88	1122	89.3	32.91



~95% of current entitlement



Present record (904.8 mV): ~80% of voltage entitlement

Voltage has <u>appeared</u> flat... ~100 mV increase relative to entitlement has been realized

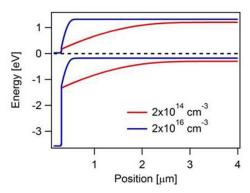
Why the historic gap?

- Minority carrier lifetime ~ ns
- Doping ~ mid-10¹⁴ cm⁻³
- Recombination at interfaces
- Electronic disorder

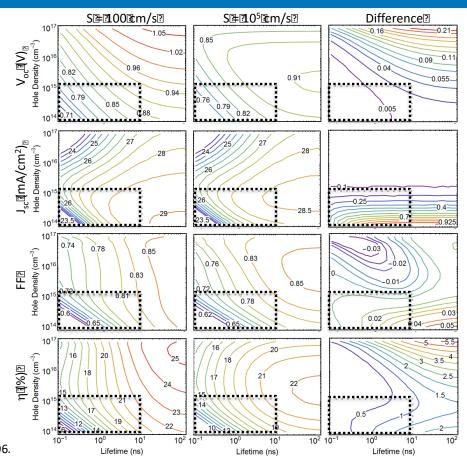
- 1. S. Ruhle "Tabulated values of the Shockley–Queisser limit for single junction solar cells" Sol. Energy 130 (2016) 139-147.
- 2. M.A. Green, et al. Prog. Photovolt.: Res. Appl. Solar Cell, "Solar Cell Efficiency Tables"; https://www.nrel.gov/pv/interactive-cell-efficiency.html
 PVCellTech 2025

A Method to Improve Voltage

- First generation devices confined to dashed boxes,
- Se-alloying enables higher lifetime,
- Realizing significant improvements requires (simultaneously):
 - High lifetime
 - High doping
 - Low interface recombination (S)

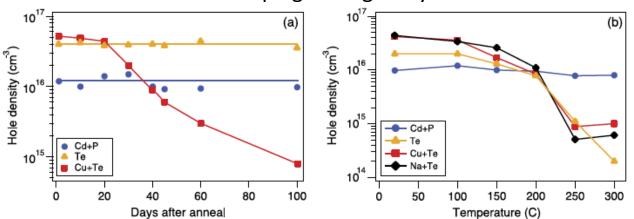


A. Kanevce, M.O. Reese et al. J. Appl. Phys. 121 (2017) 214506.

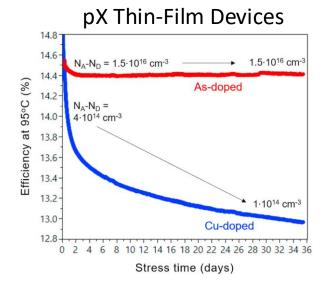


Finding a Replacement for Cu Doping





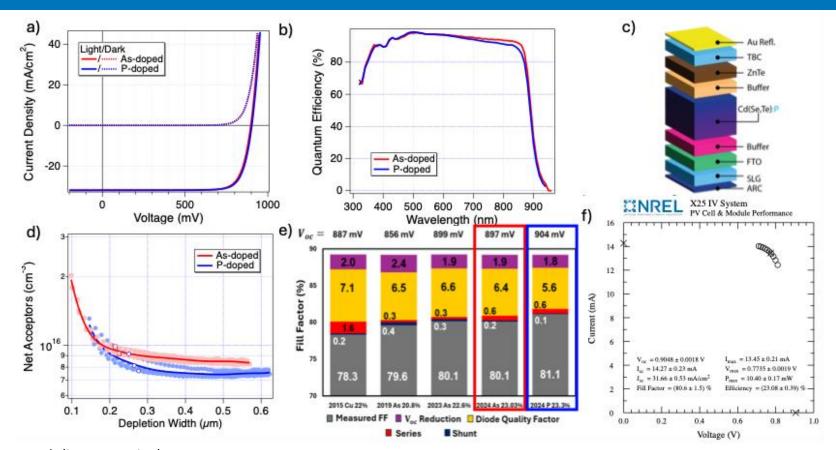
Cu is unstable with time & temperature even in single crystals



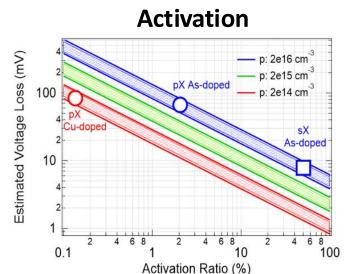
- 1. J.M. Burst, et al. APL Mater. 4 (2016) 116102.
- 2. D. Krasikov, et al. Sol. Energy Mater. Sol Cells 224 (2021) 111012.

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Recent CdTe Record Cells



Present Opportunities for Improvement

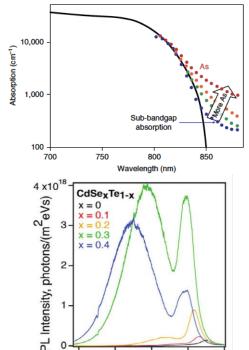


Low dopant activation may cause sizable Voc losses:

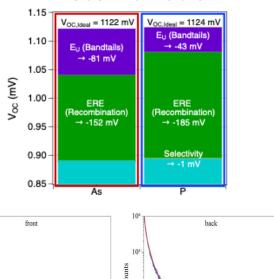
- P-doped ~ 20-50 mV
- As-doped ~ 50-100 mV

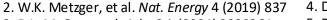
Activation is the ratio of electrically active carriers to chemically incorporated dopants

Electronic Disorder



Recombination





3. D.L. McGott et al. Adv. Sci. (2024) 2309264.

1.0

0.8

4. D. Lu et al. (in preparation)

400

5. R. Mallick et al. IEEE J. Photovolt. 13 (2023) 510.

1. B.E. Sartor et al. (under review)

1.2

Energy, eV

Time [ns]